# MSKSEMI 美森科



**ESD** 





TVC



TSS



MOV



GDT



PIFF

**SN74LVC1G3157** 

**Product specification** 





#### **DESCRIPTION**

The SN74LVC1G3157 is an advanced CMOS analog switch fabricated with silicon gate CMOS technology. It achieves very low propagation delay while maintaining CMOS low power dissipation. Analog and digital voltages that may vary across the full power-supply range (from VCC to GND).

The Select pin has over voltage protection that allows voltages above VCC, up to 7.0 V to be present on the pin without damage or disruption of operation of the part, regardless of the operating voltage.

#### **FEATURES**

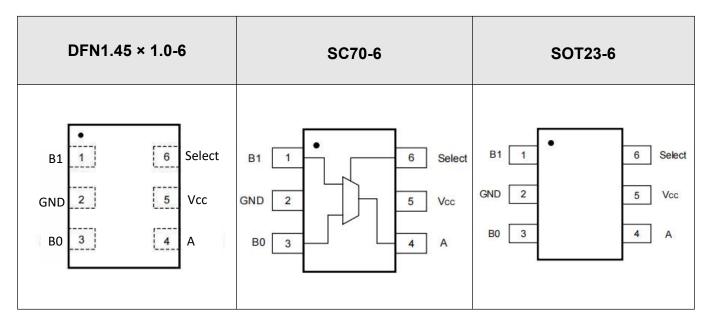
- Low power dissipation
- High speed
- Standard CMOS logic levels
- High bandwidth, improved linearity
- Switches Standard NTSC/PAL Video, Audio, SPDIF and HDTV
- be used for Clock Switching, Data Mux'ing,etc.
- Low RDSON
- Break Before Make Circuitry, Prevents Inadvertent Shorts
- Operating temperature -25℃~ +85℃
- package: SC70-6, DFN1.45 × 1.0-6, SOT23-6

## ORDER INFORMATION

Model	Package	Ordering Number	Packing Option
	DFN1.45 × 1.0-6	SN74LVC1G3157DRYR-MS	Tape and Reel, 5000
SN74LVC1G3157	SC70-6	SN74LVC1G3157DCKR-MS	Tape and Reel, 3000
	SOT23-6	SN74LVC1G3157DBVR-MS	Tape and Reel, 3000



# PIN CONFIGURATION (Top View)



## **PIN DESCRIPTIONS**

Pin	I/O	Pin Function
A, B0 , B1	I/O	Data port
Select	I	Controlling choice
VCC	1	Power supply port
GND	1	Ground

## **FUNCTIONS DESCRIPTION**

Select input port	Function
L	B0 Connected to A
Н	B1 Connected to A



#### ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Value	Unit
Supply Voltage	V <sub>CC</sub>	-0.5 ~ +7.0	V
DC Switch Voltage (1)	Vs	-0.5 ~ V <sub>CC</sub> +0.5	V
DC Input Voltage (1)	V <sub>IN</sub>	-0.5 ~ +7.0	V
DC Input Diode Current @ V <sub>IN</sub> < 0 V	I <sub>IK</sub>	-50	mA
DC Output Current	lout	128	mA
DC V <sub>CC</sub> or Ground Current	Icc/I <sub>GND</sub>	100	mA
Storage Temperature Range	Tstg	-65 ~ +150	$^{\circ}\mathbb{C}$
Junction Temperature Under Bias	T <sub>J</sub>	85	$^{\circ}\mathbb{C}$
Junction Lead Temperature (Soldering, 10 Seconds)	T <sub>L</sub>	260	$^{\circ}\mathbb{C}$
Power Dissipation @ +85°C	P <sub>D</sub>	180	mW

#### NOTE:

Stresses beyond those listed under "ABSOLUTE MAXIMUM RATINGS" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

1. The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

#### **CAUTION**

This integrated circuit can be damaged by **ESD** if you don't pay attention to **ESD** protection. recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

QCSEMI reserves the right to make any change in circuit design, specification or other related things if necessary without notice at any time. Please contact sales office to get the latest datasheet.



# **RECOMMENDED OPERATING CONDITIONS (2)**

Ch	Symbol	Min	Max	Unit	
Supply	Voltage Operating	VCC	1.65	5.5	V
Sele	ect Input Voltage	VIN	0	VCC	V
Swit	VIN	0	VCC	V	
0	utput Voltage	VOUT	0	VCC	V
Operating Temperature		TA	-25	+85	$^{\circ}\!\mathbb{C}$
Input Disc and Fall Time	Control Input VCC = 2.3 V ~ 3.6 V		0	10	no/\/
Input Rise and Fall Time	Control Input VCC = 4.5 V ~ 5.5 V	tr,tf	0	5.0	ns/V

## Note:

2. Select input must be held HIGH or LOW, it must not float.



# **ELECTRICAL CHARACTERISTICS**

	_	TA = 25°		<b>5</b> °C	TA = -25°C ~+85°C				
Symbol	Parameter	Conditions	VCC	Min	Тур	Max	Min	Max	Unit
DC ELE	CTRICAL CHA	RACTERISTICS					1		
			1.65 ~ 1.95				0.75Vcc		
	High Level Input		2.3 ~ 2.8				1.5		V
VIH	Voltage		3 ~ 4.2				2.4		
			4.5 ~ 5.5				0.6Vcc		
			1.65 ~ 1.95					0.25VCC	
VIL	Low Level Input Voltage		2.3 ~ 2.8					0.4	V
			3 ~ 5.5					0.3Vcc	
liN	Input Leakage Current	0 < VIN < 5.5 V	0 ~ 5.5		±0.05	±0. 1		±1	uA
IOFF	OFF State Leakage Current	0 < A, B < Vcc	1.65 ~ 5.5		±0.05	±0. 1		±1	uA
ICC	Quiescent Supply	VIN = Vcc or GND IOUT = 0	5.5			1.0		10	uA
	Analog Signal Range		VCC	0		VCC	0	VCC	V
		VIN = 0 V, IO = 30 mA			3.0			7.0	Ω
		VIN = 2.4 V, IO = -30 mA			5.0			12	Ω
		VIN = 4.5 V, IO = -30 mA	4.5		7.0			15	Ω
		VIN = 0 V, IO = 24 mA			4.0			9.0	Ω
		VIN = 3 V , IO = -24 mA	3.0		10			20	Ω
RON	Switch On Resistance <sup>(3)</sup>	VIN = 0 V, IO = 8 mA			5.0			12	Ω
	Resistance	VIN = 2.3 V, IO = -8 mA	2.3		13			30	Ω
		VIN=0V, IO =4 mA			6.5			20	Ω
		VIN = 1.65 V, IO = -4 mA	1.65		17			50	Ω
	On Resistance	IA = -30 mA 0 ≤ VBn ≤ VCC	4.5					25	Ω
RRANGE	Over Signal Range <sup>(3)(7)</sup>	IA = -24 mA 0 ≤ VBn ≤ VCC	3					50	Ω



# **ELECTRICAL CHARACTERISTICS (continued)**

o	_	T			TA = 25	°C	TA = -2	5°C ~ +85°C	
Symbol Parameter	Test Conditions	vcc	Min	Тур	Max	Min	Max	Unit	
	On Resistance Over Signal	IA = -8 mA 0 ≤ VBn ≤ VCC	2.3					100	Ω
RRANGE	Range(3)(7)	IA = -4 mA 0 ≤ VBn ≤ VCC	1.65					300	Ω
		IA = -30 mA VBn = 3.15	4.5		0.15				Ω
		IA = -24 mA VBn = 2.1	3		0.2				Ω
A DON	On Resistance Match Between	IA = -8 mA VBn = 1.6	2.3		0.5				Ω
∆ RON	Channels(3)(4)(5)	IA = -4 mA VBn = 1.15	1.65		0.5				Ω
		IA = -30 mA 0 ≤ VBn ≤ VCC	5		6.0				Ω
		IA = -24 mA 0 ≤ VBn ≤ VCC	3.3		12				Ω
DEL AT	On Resistance	IA = -8 mA 0 ≤ VBn ≤ VCC	2.5		28				Ω
RFLAT	Flatness(3)(4)(6)	IA = -4 mA 0 ≤ VBn≤ VCC	1.8		125				Ω
C ELECT	RICAL CHARACT	ERISTICS							
			1.65 ~ 1.95						nS
	Propagation		2.3 ~ 2.7					1.2	nS
tPHL	Delay Bus to	Figure 1	3.0 ~ 3.5					0.8	nS
tPLH	Bus (8)	VI = OPEN	4.5 ~ 5.5					0.3	nS
	Output Enable	Figure 1	1.65 ~ 1.95			23	7.0	24	nS
tPZL	Time,	VI = 2*VCC for	2.3 ~ 2.7			13	3.5	14	nS
tPZH	Turn On Time	tPZL ,VI = 0 V for	3.0 ~ 3.5			6.9	2.5	7.6	nS
ıг∠∏ 	(A to Bn)	tPZH	4.5 ~ 5.5			5.2	1.7	5.7	nS
			1.65 ~ 1.95			12.5	3.0	13	nS
	Output Disable	Figure 1	2.3 ~ 2.7			7.0	2.0	7.5	nS
tPLZ	Time, Turn Off Time (A Port to	VI = 2*VCC for tPLZ ,VI = 0 V for	3.0 ~ 3.5			5.0	1.5	5.3	nS
tPHZ									



# **ELECTRICAL CHARACTERISTICS (continued)**

Symbol	Parameter	Test Conditions		Т	A = 2	<b>5</b> °C	TA = -25	°C ~ +85°C	
Symbol	Farameter		VCC	Min	Тур	Max	Min	Max	Unit
			1.65 ~ 1.95				0.5		nS
	Break Before	Figure2 ,	2.3 ~ 2.7				0.5		nS
tB-M	Make Time (7)	CL = 50 pF ,	3.0 ~ 3.5				0.5		nS
	Make Time \ /	RL = 600 Ω	4.5 ~ 5.5				0.5		nS
		Figure 3, CL = 0.1 nF ,	5.0		7.0				pC
Q	<sup>(7)</sup> Charge Injection	VGEN = 0 V , RGEN = 0 Ω	3.3		3.0				pC
OIRR	Off Isolation <sup>(9)</sup>	Figure 4, RL = $50 \Omega$ , f = $10MHz$	1.65 ~ 5.5		-57				dB
		Figure 5,							
Xtalk	Crosstalk	RL= 50 Ω , f = 10MHz	1.65 ~ 5.5		-54				dB
BW	−3 dB Bandwidth	Figure 8, RL = 50 Ω	1.65 ~ 5.5		350M				Hz
THD	Total Harmonic Distortion <sup>(7)</sup>	RL = 600 Ω, 0.5VP-P f = 600 Hz ~ 20 kHz	5.0		0.011				%
CIN	Select Pin Input Capacitance (10)		0		2.3				pF
CIO-B	B Port Off Capacitance (10)	Figure 6	5.0		5.0				pF
CIOA- O N	A Port Capacitance when Switch is Enabled <sup>(10)</sup>	Figure 7	5.0		15.5				pF



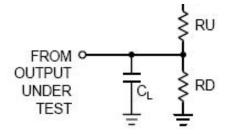
#### Note:

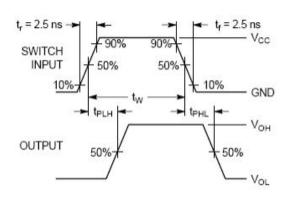
- 3. Measured by the voltage drop between A and B pins at the indicated current through the switch. On Resistance is determined by the lower of the voltages on the two (A or B Ports).
- 4. Parameter is characterized but not tested in production.
- 5. Δ RON = RON max RON min measured at identical VCC, temperature and voltage levels.
- 6. Flatness is defined as the difference between the maximum and minimum value of On Resistance over the specified range of conditions.
- 7. Guaranteed by Design.
- 8. This parameter is guaranteed by design but not tested. The bus switch contributes no propagation delay other than the RC delay of the On Resistance of the switch and the 50 pF load capacitance, when driven by an ideal voltage source (zero output impedance).
- 9. Off Isolation = 20 log10 [VA/VBn].
- 10. TA = +25°C, f = 1 MHz, Capacitance is characterized but not tested in production.

#### **TEST CIRCUITS**

NOTE: Input driven by 50  $\Omega$  source terminated in 50  $\Omega$ 

NOTE: C<sub>L</sub> includes load and stray capacitance NOTE: Input PRR = 1.0 MHz; t<sub>W</sub> = 500 ns





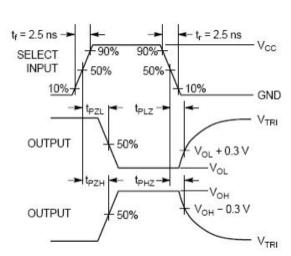
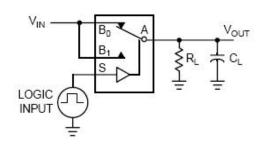


Figure 1. AC Test Circuit ,AC Waveforms



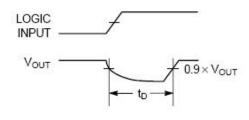


Figure 2. Break Before Make Interval Timing



# **TESTCIRCUITS(continued)**

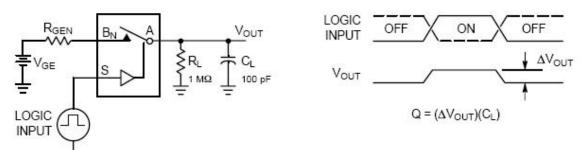


Figure 3. Charge Injection Test

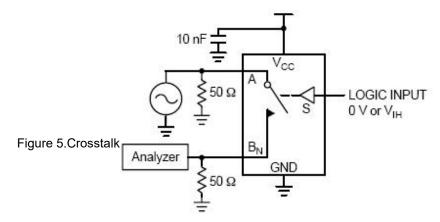


Figure 4. Off Isolation

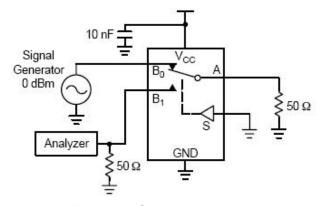


Figure 5.Crosstalk

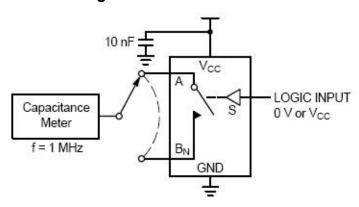


Figure 6. Channel Off Capacitance



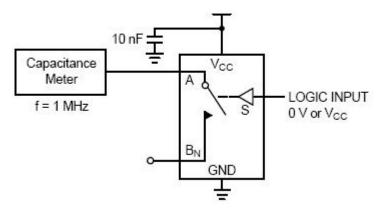


Figure 7. Channel On Capacitance

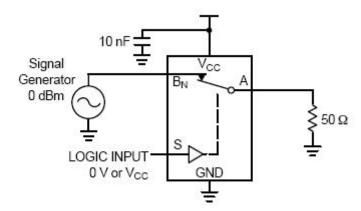
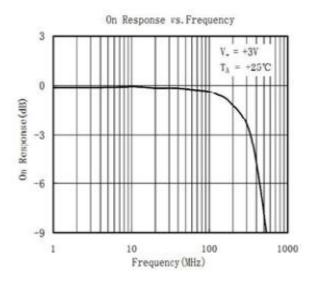
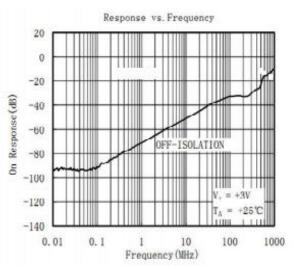
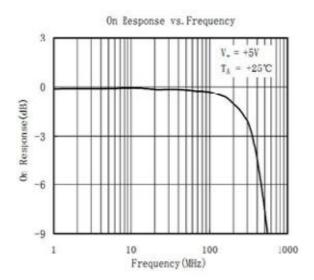


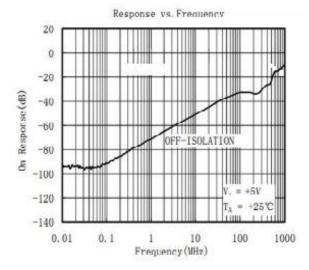
Figure 8. Bandwidth







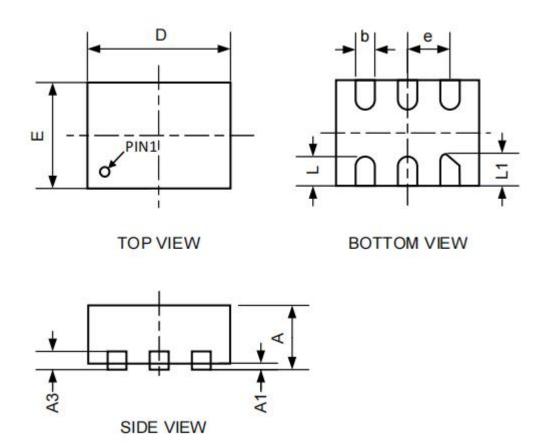






# **PACKAGE OUTLINE**

DFN1.45 × 1.0-6

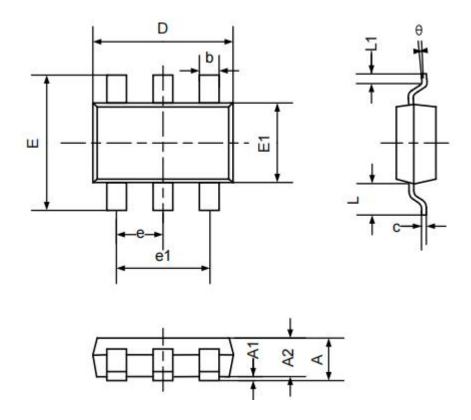


Symbol	Dimensions in Millimeters				
	Min	Nom	Max		
A	0.50	0.55	0.60		
A1	0.00	0.05			
A3	0.15REF				
D	1.40	1.45	1.50		
E	0.95	1.00	1.05		
b	0.18	0.28			
e	0.50BSC				
L	0.25 0.35 0.4				
L1	0.30	0.40	0.50		



# **PACKAGE OUTLINE**

C70-6

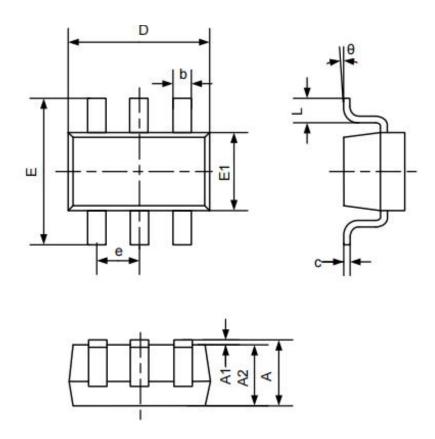


Symbol	Dimensions in Millimeters				
	Min	Max			
A	0.85	1.05			
A1	0.00	0.10			
A2	0.80	1.00			
b	0.15	0.35			
С	0.08	0.22			
D	2.02	2. 12			
E	2.20	2.40			
E1	1.25	1.35			
е	0	.65BSC			
e1	1	.30BSC			
L	0.50REF				
L1	0.28	0.38			
θ	0°	8°			



# **PACKAGE OUTLINE**

SOT-23-6



Symbol	Din	Dimensions in Millimeters				
	Min	Nom	Max			
A			1.240			
A1	0.010	0.050	0.090			
A2	1.050	1.100	1.150			
b	0.300	0.350	0.400			
С	0.117		0.157			
D	2.870	2.920	2.970			
E	2.720	2.800	2.880			
E1	1.550	1.600	1.650			
е	0.950BSC					
1	1.900BSC					
L	0.320	0.320 0.400 0.48				
θ	0°		5°			



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